

Epitaxial Oxide Growth in ErH_2 Thin Films

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INTRODUCTION

- Neutron generators (NGs, Figure 1) are devices used to produce high-energy neutrons
- Neutron generators are important components of nuclear weapons
- Neutrons are generated by accelerating deuterium (D, isotope ^2H) into a rare-earth tritide (T, isotope ^3H) target
- Erbium ditritide (ErT_2) is a commonly used target material
- However, the microstructural properties of ErT_2 are not yet well understood
- In this work, the distribution and crystallography of erbium oxide (Er_2O_3) contamination in films of erbium dihydride (ErH_2) were examined to simulate the radioactive tritiated system ErT_2

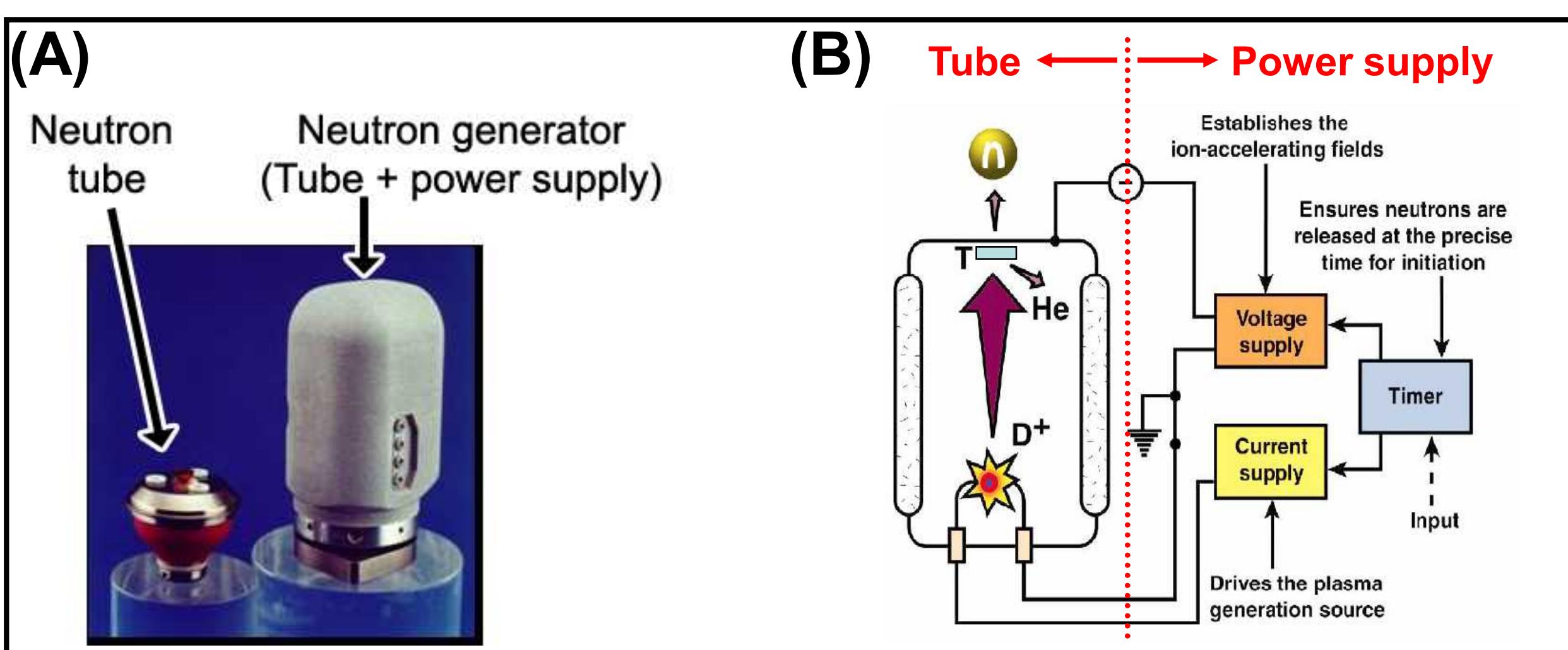


Figure 1: (A) Photograph of a neutron generator system. (B) Schematic illustration of a neutron generator.

PROCEDURE

- Erbium metal films ~500 nm thick were deposited onto a 100 nm molybdenum interlayer on a (100) Si substrate
- The erbium films were then hydrided into ErH_2
- ErH_2 has the fluorite $\text{Fm}\bar{3}\text{m}$ crystal structure, Figure 2A
- Bixbyite-structured $\text{Ia}\bar{3}$ Er_2O_3 , Figure 2B, forms unintentionally during crystal growth
- Samples were prepared by focused-ion-beam lift-out using an FEI dual-beam instrument, with 2-5 keV final polishing
- Samples were examined in a Phillips CM30 TEM/STEM operated at 300 keV

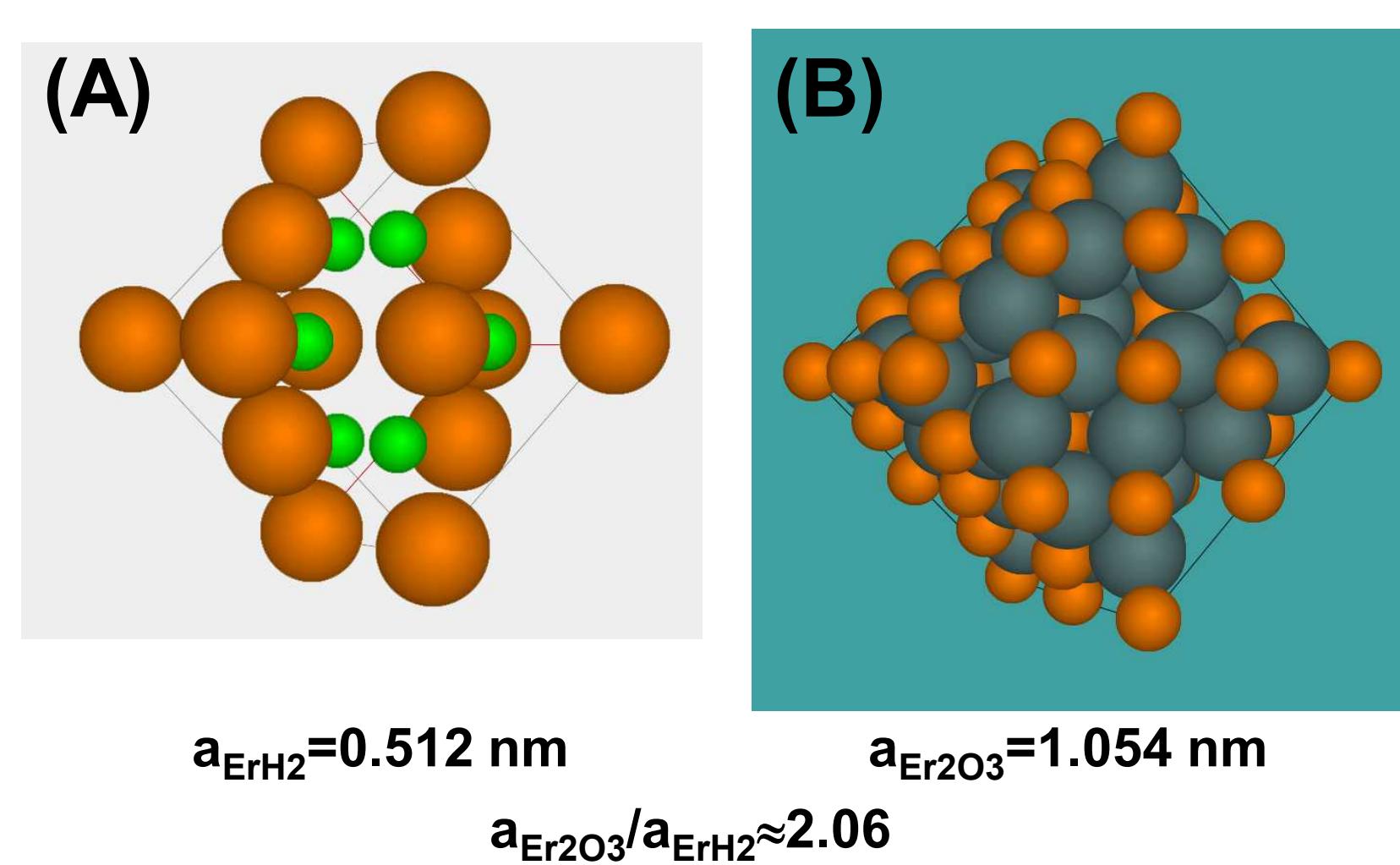


Figure 2: (A) Fluorite-structured ErH_2 , (B) Bixbyite-structured Er_2O_3 .

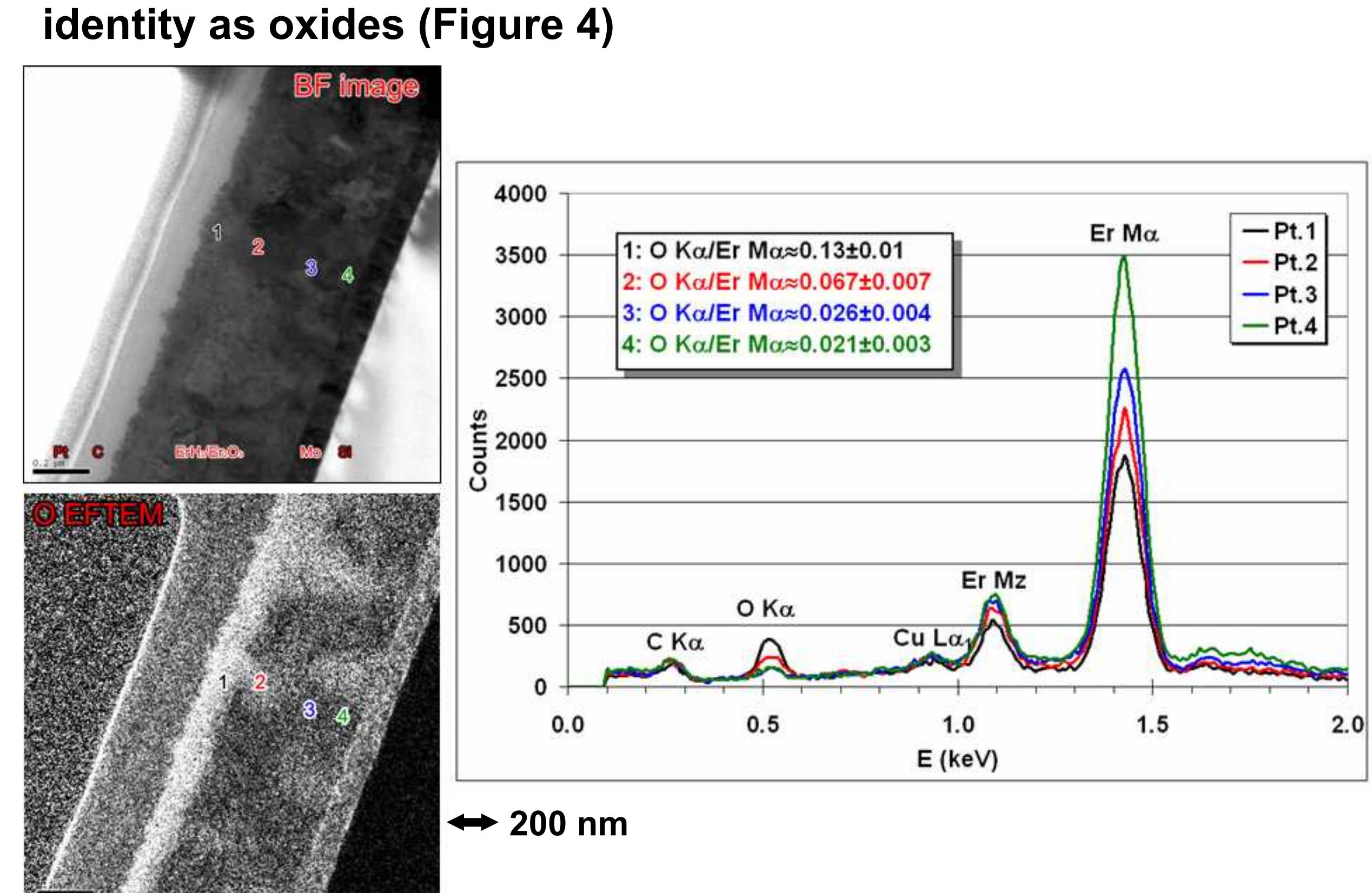


Figure 4: Comparison of BF image, EDS point-spectra, and EFTEM oxygen map.

- EFTEM shows a 100-150 nm thick oxide layer on the surface of the film, as well as large oxides within the film (Figure 5)

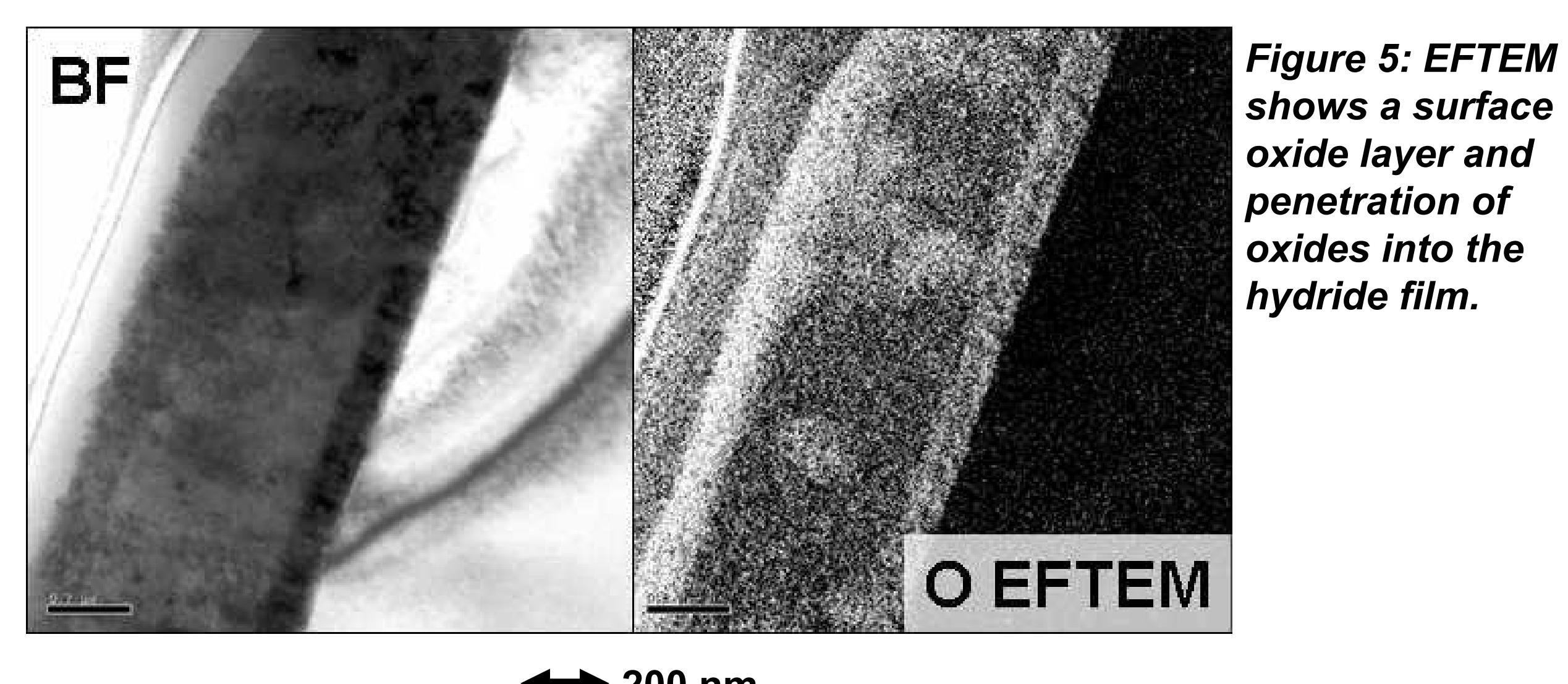


Figure 5: EFTEM shows a surface oxide layer and penetration of oxides into the hydride film.

- Tilting to a zone-axis orientation results in strong dynamical contrast in both top (oxide) and bottom (hydride) layers (Figure 6)

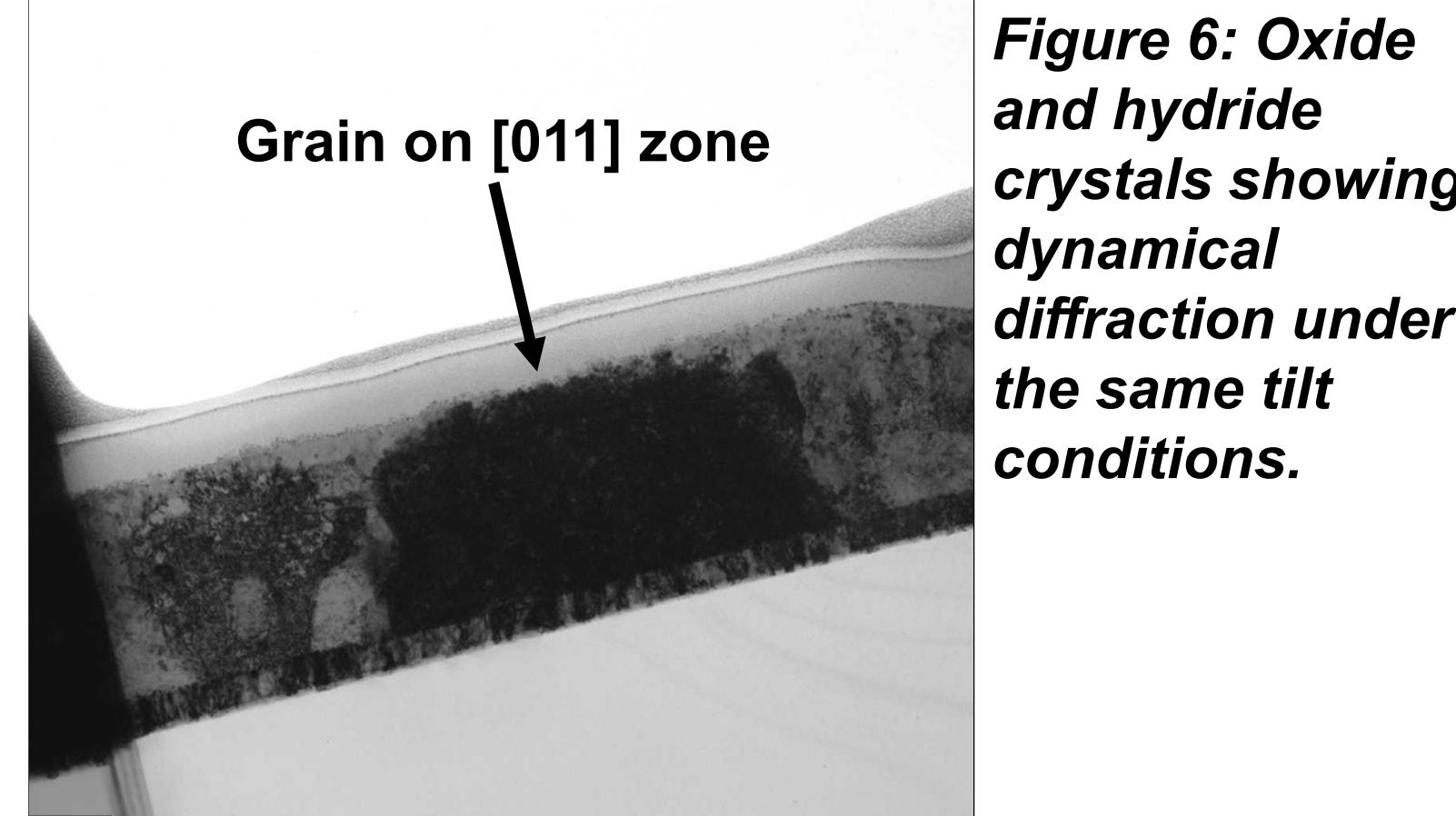


Figure 6: Oxide and hydride crystals showing dynamical diffraction under the same tilt conditions.

- SAD of the hydride shows a [011] type zone-axis diffraction pattern (ZADP) with unexpected satellite spots (Figure 7); satellite spots were observed in all hydride diffraction patterns
- SAD of the oxide shows streaking of the major oxide spots, which may indicate a slight mosaic structure (Figure 8)
- SAD of both layers indicates a strongly epitaxial relation (Figure 9)

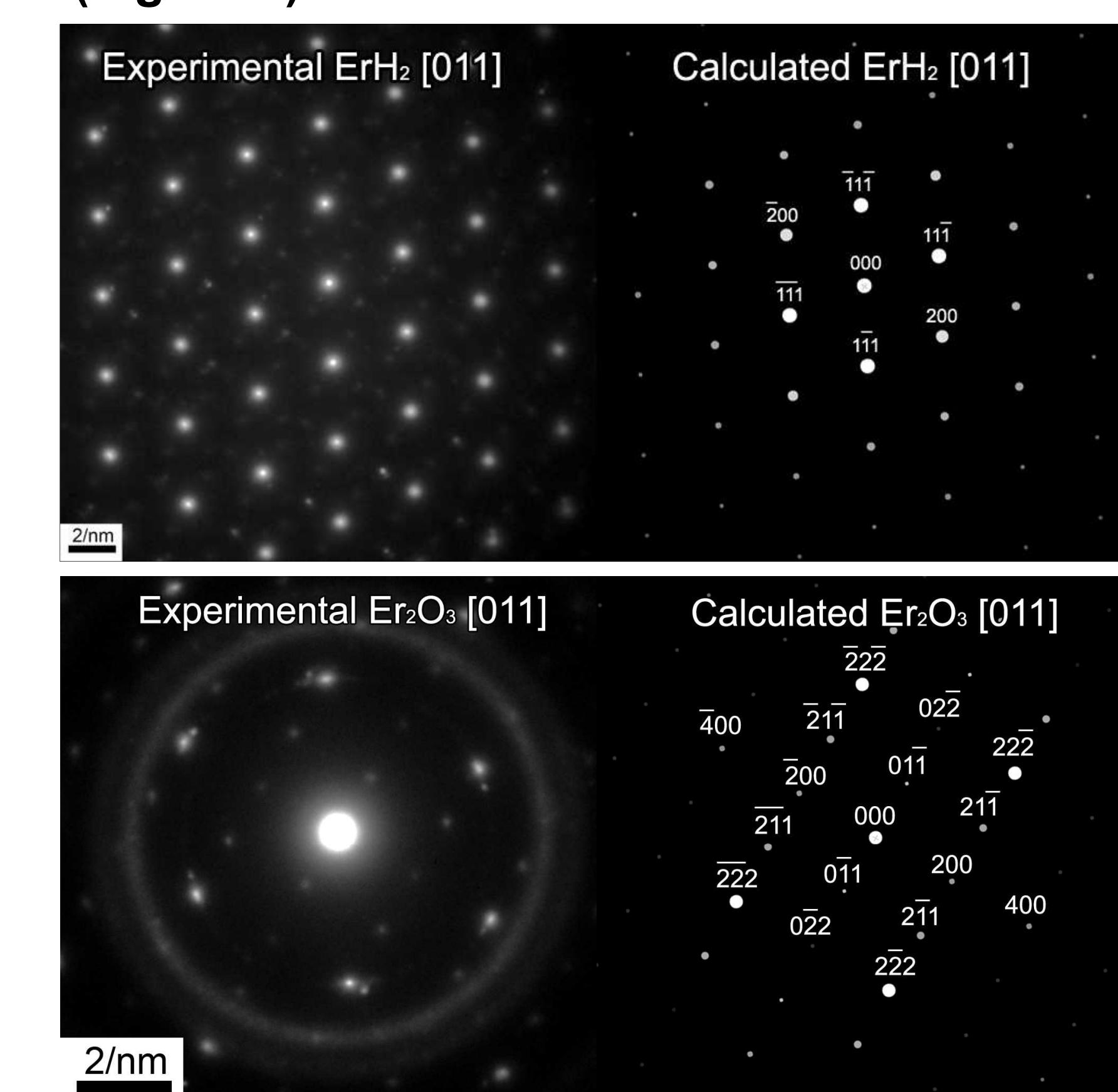


Figure 7: [011] type SAD pattern of the hydride grain in Figure 6. Satellite spots are not expected from the fluorite-based ErH_2 structure

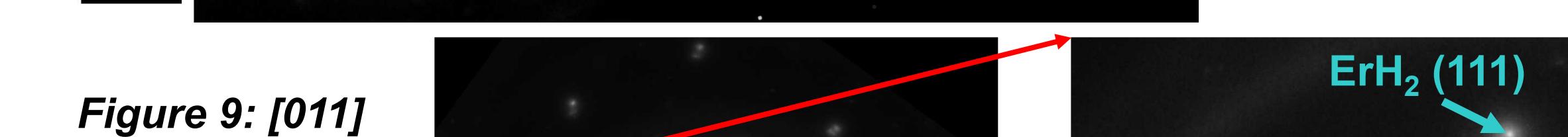
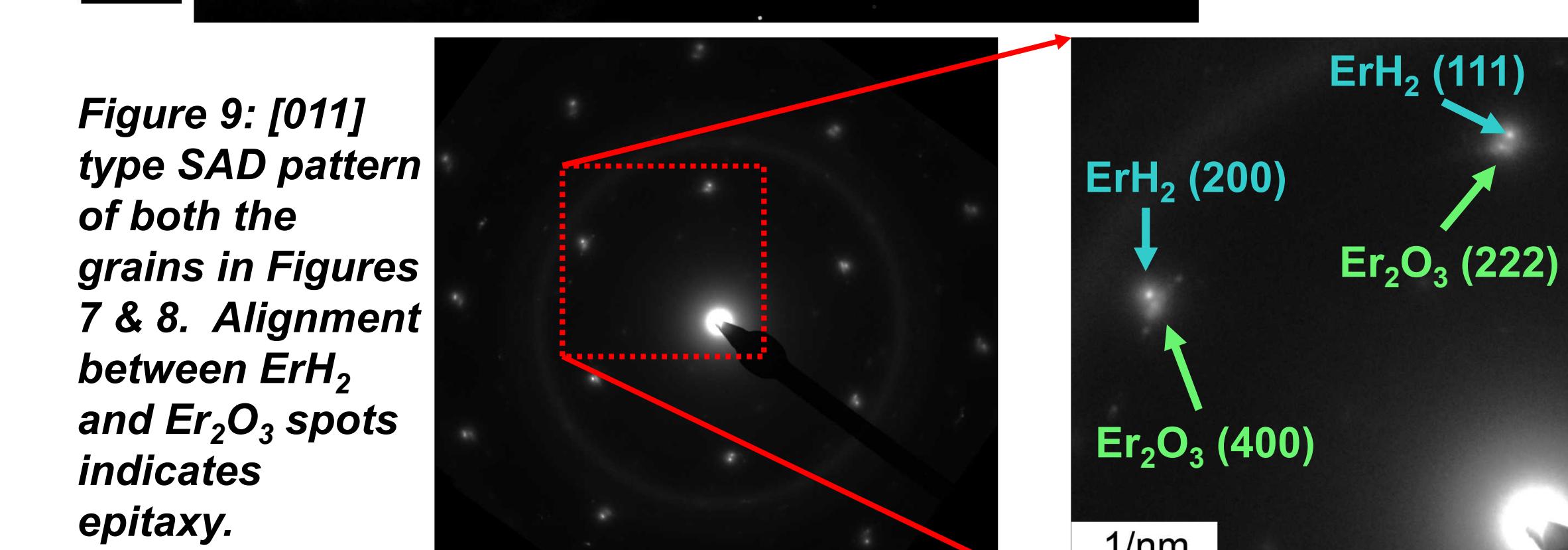


Figure 8: [011] type SAD pattern of the oxide layer in Figure 6.



- To determine the orientation relation, an oxide layer and associated hydride grain (Figure 10) were tilted to a series of zone axis orientations (Figure 11)

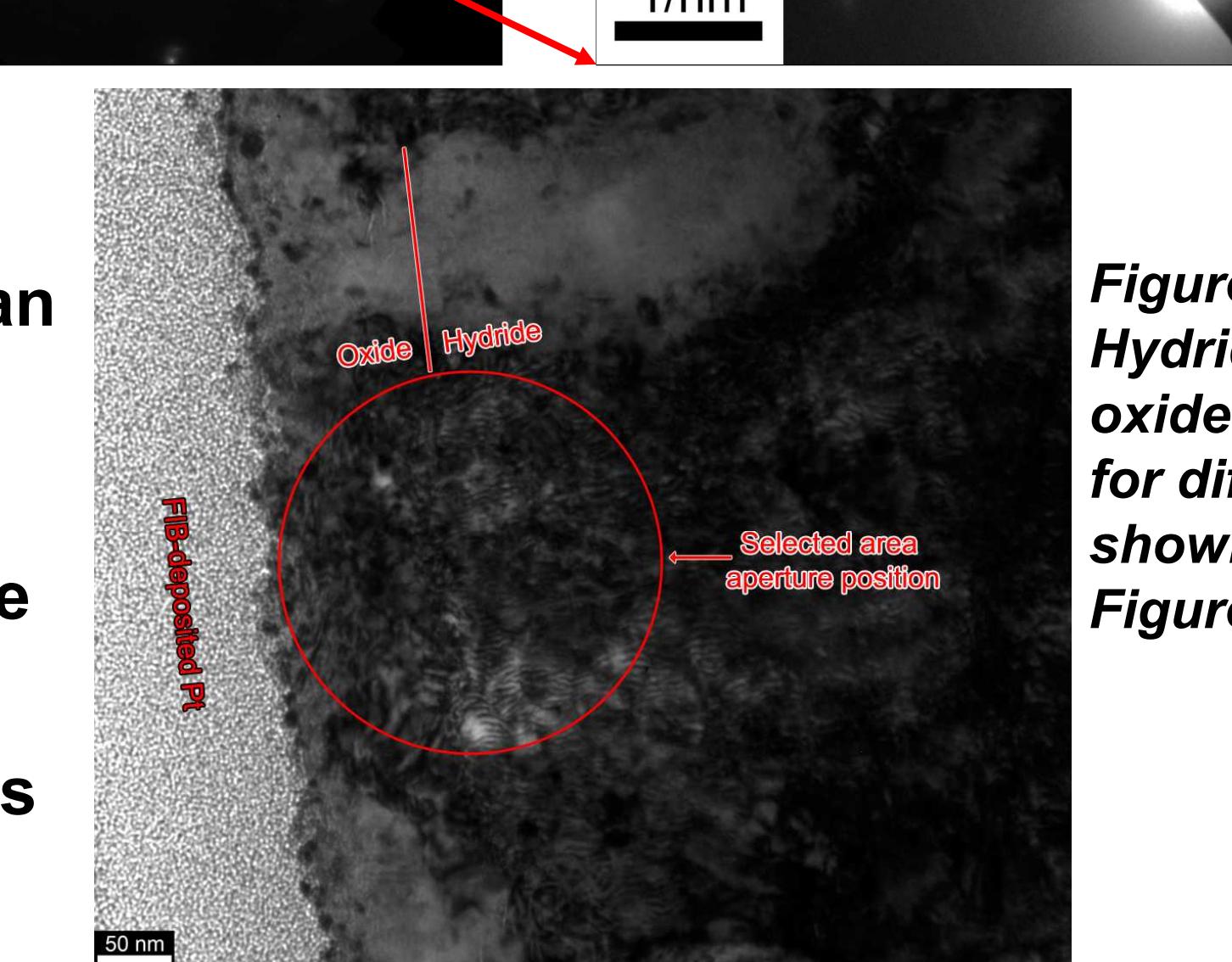


Figure 10: Hydride and oxide grains for diffraction shown in Figure 11

- The registry between the $(\text{hkl})_{\text{hydride}}$ and $2(\text{hkl})_{\text{oxide}}$ reflections in Figure 11 are indicative of a cube-on-cube epitaxial relationship

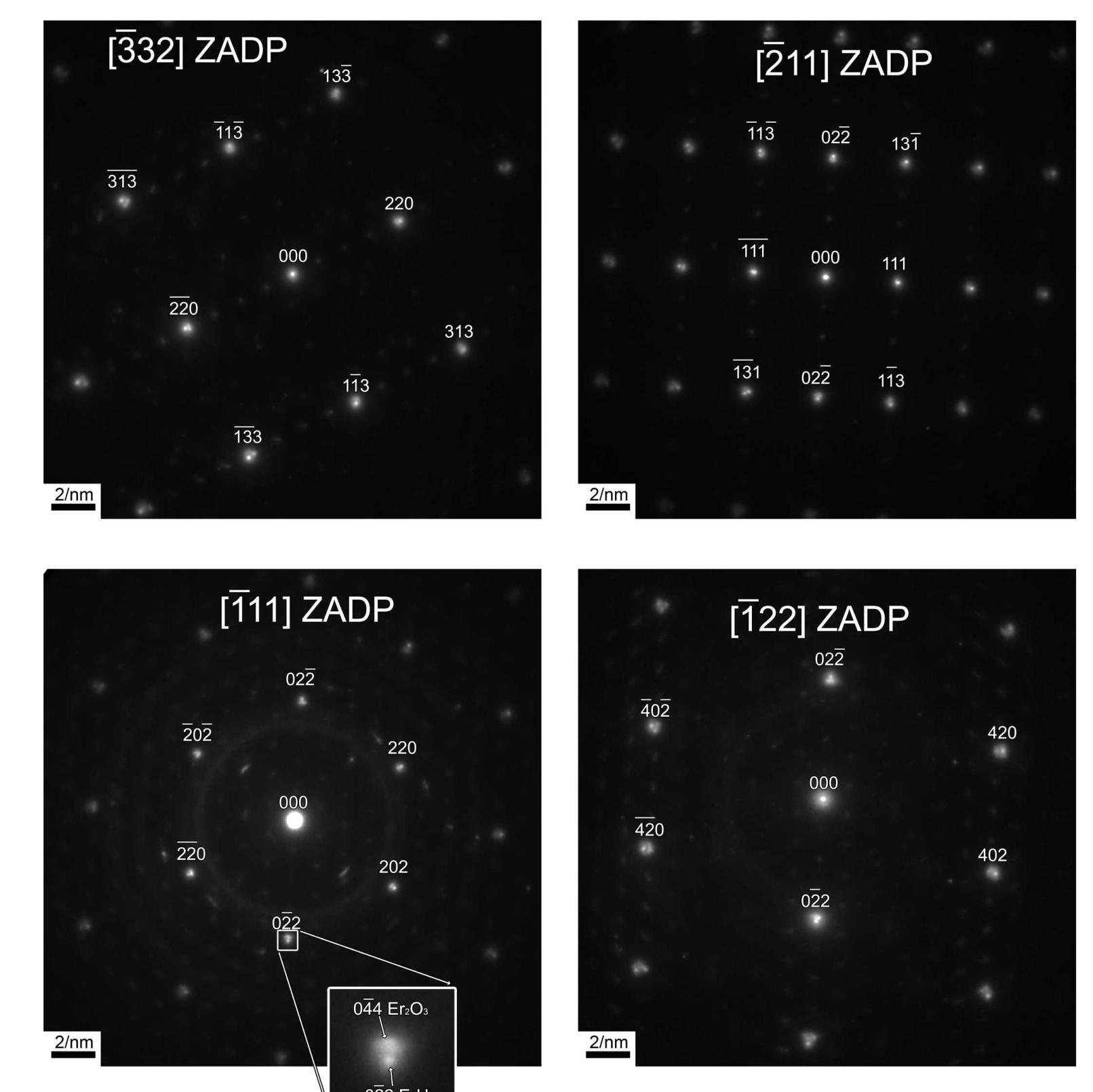


Figure 11: ZADPs of the grains shown in Figure 10. Labels are the ErH_2 reflections. All major spots show an associated Er_2O_3 reflection, as illustrated in the inset to $\bar{1}11$.

- As seen in Figure 7, ErH_2 SADPs have satellite spots not predicted from the hydride crystal structure
- It is speculated that these satellite spots arise from double-diffraction off Er_2O_3 nanocrystals in a hydride matrix
- In Figure 12, a grain was tilted ~4° of $\langle 011 \rangle$ into a near $\{111\}$ two-beam condition
- Figure 12 shows the BF image, and DF image taken with the reflection marked in the diffraction pattern
- The DF image shows small (~10 nm) particles, possibly Er_2O_3
- High-resolution TEM is currently underway to determine if the small particles are oxides

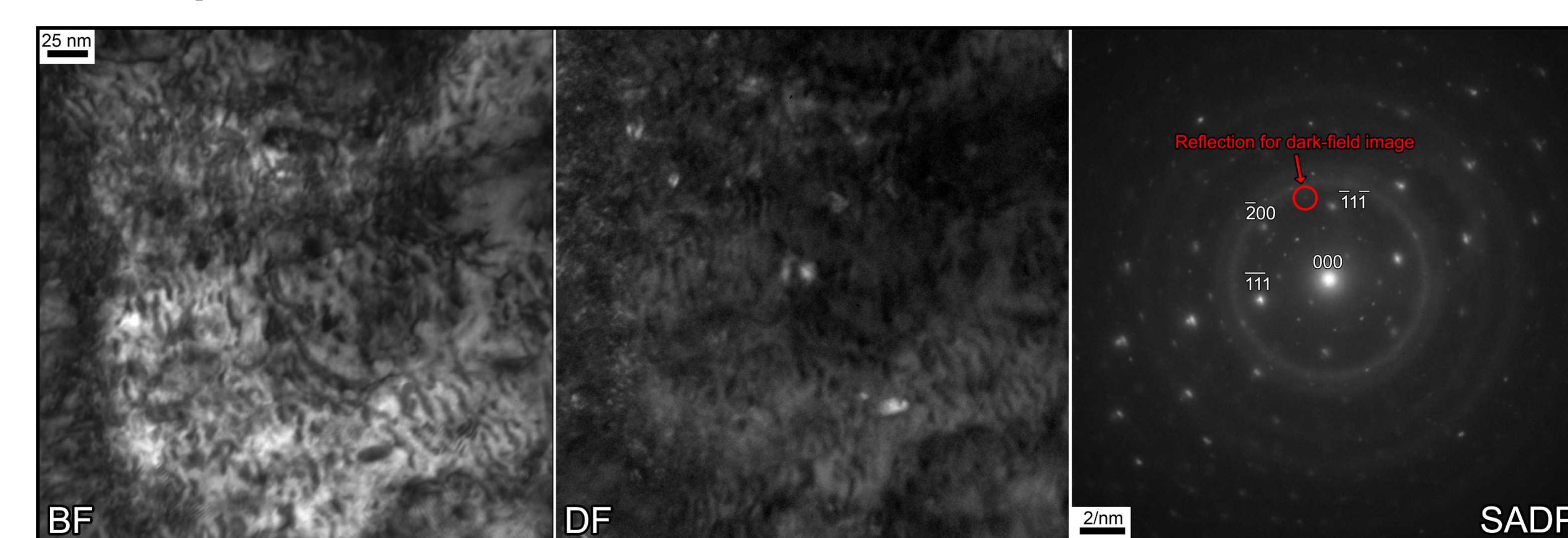


Figure 12: A BF image of a hydride grain, and associated DF image showing small inclusions arising from a diffraction spot not associated with the hydride crystal structure. It is speculated the spots may be double diffraction, and the inclusions are oxide.

CONCLUSIONS

- Erbium hydride films are confirmed by EFTEM, EDS, and SAD to suffer from growth of unwanted oxide particles
- An oxide surface film tends to grow in a cube-on-cube orientation
- It is possible that the hydride matrix is contaminated with small oxide inclusions; further investigations are underway